Straw based and solid state based TRDs for SAS

Nicola Mazziotta and Francesco Loparco

INFN Bari

mazziotta@ba.infn.it

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Introduction

- The aim of this work is twofold:
 - Study of the configuration of a single TRD module
 - Study of the performance of a multi-module TRD
- TRD configurations:
 - Straw:
 - Radiators with 200 foils and d1(μm)/d2(μm) = 15/300, 50/1000 and 100/2000 (hereafter thin, middle and thick configuration)
 - Up to 40 layers of straws (2 mm radius) in close pack configuration filled with Xe/CO2 80/20
 - Solid state:
 - Radiator with 200 foils and d1(μm)/d2(μm)=100/2000 (i.e. thick)
 - Up to 100 layers of silicon 60 µm thick
- Full Monte Carlo simulations implemented for both options
 - Computer Physics Communications 132 (2000) 110–123
 - Nuclear Instruments and Methods in Physics Research A 533 (2004) 322–343

Straw TRD geometry



- Radiators with 200 foils and $d1(\mu m)/d2(\mu m) = 15/300, 50/1000$ and 100/2000 (thin, middle and thick configurations)
- Up to 40 layers of straws (2 mm of radius) in close pack configuration filled with Xe/CO2 80/20
- The events have been uniformly generated across the first straw tube
- The plot shows the position of the pair due to the ionization energy loss (10⁵ events)
 - In this work we will use only the information on the energy loss

Solid state TRD module

- The ionization energy loss in solid medium is usually larger than the TR energy
 - A magnetic field could be used to separate the particle from the TR photons (SiTRD concept)
 - This is unpractical for the SAS project
- A possible solution could be to minimize the solid state detector thickness
 - On the shelf we found silicon detectors of about 60 μm thickness
- Geometry of a single module:
 - Radiator with 200 foils and d1(μm)/d2(μm)=100/2000 (i.e. thick)
 - Up to 100 layers of silicon 60 μm thick



Straw based TRD

Thin configuration – Energy loss Energy deposition in the 1st layer



With TR

30

With TR

30

35

40

Without TR

35

40

Without TR

50

45 50 Energy (keV)

50

Middle configuration – Energy loss deposition in the 1st layer Energy deposition in the 2nd layer



Thick configuration – Energy loss



Single module analysis

- Number of fired layers as a function of the energy threshold (i.e. 3, 4, 5 and 6 keV)
- Efficiency as a function of the energy threshold (i.e. 3, 4, 5 and 6 keV)
 - The efficiency has been evaluated averaging the energy losses in a given number of first layers
- These studies have been performed in the saturation regime, i.e. with 10 TeV pions

Thin configuration – Fired layers



Middle configuration – Fired layers



Cumulative layer

Thick configuration – Fired layers



Thin configuration - Efficiency



Middle configuration - efficiency



Thick configuration - Efficiency



Configuration of a straw TRD module

- According to the results shown in the previous slides the optimal number of straw layers for a single TRD module could be:
 - Thin configuration: 4 straw layers
 - 2 layers could work the same
 - Middle configuration: 8 straw layers
 - 4 layers could work the same
 - Thick configuration: 16 straw layers
 - 8 layers could work the same

Thin configuration – Number of hit layers



Middle configuration – Number of hit layers

Pol/Air, 50 µm/ 1000 µm, Nf=200, Straw layer=4



Pol/Air, 50 µm/ 1000 µm, Nf=200, Straw layer=8



Thick configuration – Number of hit layers

Pol/Air, 100 μm/ 2000 μm, Nf=200, Straw layer=8



Pol/Air, 100 µm/ 2000 µm, Nf=200, Straw layer=16



Likelihood analysis (for multiple modules)

- For each configuration, the distributions of the average energy deposited in the layers composing a module has been evaluated
- A (pseudo) multi-module configuration has been simulated extracting sets of random energy values {E_i} from the single module distribution
- The likelihood function for particles of the species A and B is defined as

 $\mathcal{L}_A = \frac{P_A}{P_A + P_B}$

 $P_A = \prod_i^N P_A(E_i), P_B = \prod_i^N P_B(E_i)$

- The contamination of a particle B is then calculated at 90% efficiency of the particle A
- By definition:
 - if $A \sim B \implies \mathcal{L}_A \sim 0.5$
 - contamination $\Rightarrow 0.1$
 - if $A \neq B$ the distribution of \mathcal{L}_A (\mathcal{L}_B) peaks at 1 (0)

Thin configuration – multi-module

Pol/Air, 15 µm/ 300 µm, Nf=200, Number of Layers=4, Number of Modules=5

Pol/Air, 15 µm/ 300 µm, Nf=200, Number of Layers=4, Number of Modules=10



Middle configuration – multi-module

Pol/Air, 50 µm/ 1000 µm, Nf=200, Number of Layers=8, Number of Modules=5

Pol/Air, 50 µm/ 1000 µm, Nf=200, Number of Layers=8, Number of Modules=10





Thick configuration – multi-module

Pol/Air, 100 µm/ 2000 µm, Nf=200, Number of Layers=16, Number of Modules=10

Pol/Air, 100 µm/ 2000 µm, Nf=200, Number of Layers=16, Number of Modules=5







Solid state TRD

Analysis steps

- Study of the distributions of energy deposited in the individual silicon planes
- Number of fired layers as a function of the energy threshold (i.e. 20, 30, 40 and 50 keV)
- Efficiency as a function of the energy threshold (i.e. 20, 30, 40, 50 keV)
 - The efficiencies of individual layers have been evaluated
 - For each value of the threshold the overall efficiency has been evaluated as a function of the minimum number of fired layers
- These studies have been performed in the saturation regime, i.e. with 10 TeV pions

Energy depositions in the silicon planes (1)



Energy depositions in the silicon planes (2)



Average energy depositions in Si planes



Efficiency of individual Si planes



Number of fired planes



Efficiency vs number of planes



Conclusions

- The work is still in progress!!!
- The straw based TRD could work even with radiators made with thick foils
- The solid state based TRD with thin silicon detectors needs to be further investigated, but...
 - It does not provide a clean identification of radiating/non-radiating particles, even with a high number of silicon planes
 - Although we chose a configuration with very thin silicon detectors, the MIP energy loss in each plane is close to the TR X-ray energies
 - Better result could be obtained applying a maximum likelihood analysis to the energy depositions in each silicon plane (to be investigated)
 - It could work with thicker radiator foils (harder X-rays) or thinner Si detectors (lower ionization losses)
 - However a silicon pixel detector could be used in case of a RingTRD, since in this case the TR X-rays will be separated from the ionizing particle
- Bonus: good tracking devices even at high rates!

Extra slides

Thin RAD - spectrum



Middle RAD - spectrum



Thick RAD - spectrum

